Search Notes		

Applicat	ion/Control	No.

Applicant(s)/Patent under Reexamination

09/943,780

BAKER ET AL.
Art Unit

Examiner

David J. Blanchard	1643

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	,		
SEQ IC	NO:69	1/25/2007	DB

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
STIC search SEQ ID NO:69 (SCORE results in related USSN 10/677,669)	1/25/2007	DB
	,	·
<u> </u>		
		· <u>-</u> ·
		•